## Search Notes

Search Notes			

Application/Control No.	Applicant(s)/Patent Unde
	Reexamination

10583389 KATO ET AL.

Examiner Art Unit

Dawn Garrett 1794

## SEARCHED

Class	Subclass	Date	Examiner
428	690, 917 (see EAST search history printout for all listed class/subclasses - limited by keywords)	8-21-08	DG
313	504	8-21-08	DG
526	239, 241	8-21-08	DG
252	301.16, 301.35	8-21-08	DG
257	40, E51.033, E51.036, E51.044	8-21-08	DG

## SEARCH NOTES

SEARCH NOTES			
Search Notes	Date	Examiner	
STIC structure search (done by EIC 1700 - E. Linnell) - see attached printout	8-21-08	DG	
Inventor Name Search	8-21-08	DG	
EAST search (see search history printout) - Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	8-21-08	DG	
Reviewed U.S. provisional application	8-21-08	DG	
Reviewed 371 International Search Report	12-10-08	DG	
Reviewed prior STIC structure search (8/2008)	12-10-08	DG	
updated Inventor Name Search	12-10-08	DG	
updated EAST search (see search history printout) - Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-10-08	DG	

## INTERFERENCE SEARCH

	Class	Subclass	Date	Examiner
		Interference search done in EAST, keywords searched in claim field, USPAT and USPGPUB databases (see	12-10-08	DG
		attached INTERFERENCE SEARCH printout)	1	1